







SN54HCT245, SN74HCT245 SCLS020H - MARCH 1984 - REVISED DECEMBER 2022

SNx4HCT245 Octal Bus Transceivers With 3-State Outputs

1 Features

- Operating voltage range of 4.5 V to 5.5 V
- High-Current 3-state outputs drive bus lines directly or up to 15-LSTTL loads
- Low power consumption, 80-µA maximum I_{CC}
- Typical t_{pd} = 14 ns
- ±6-mA output drive at 5 V
- Low input current of 1 µA maximum
- Inputs are TTL-voltage compatible

2 Applications

- **Factory Automation and Control**
- **Grid Infrastructure**
- Electronic Point of Sale
- Multi-Function Printers
- **Motor Drives**
- Storage
- Telecom Infrastructure

3 Description

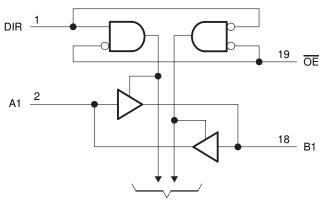
The SNx4HCT245 bus transceivers octal are designed for asynchronous two-way communication between data buses. The controlfunction implementation minimizes external timing requirements.

The SNx4HCT245 devices allow data transmission from the A bus to the B bus or from the B bus to the A bus, depending upon the logic level at the directioncontrol (DIR) input. The output-enable (\overline{OE}) input can be used to disable the device so that the buses are effectively isolated.

Device Information

| PART NUMBER | PACKAGE ⁽¹⁾ | BODY SIZE (NOM) | | |
|-------------|------------------------|--------------------|--|--|
| | J (CDIP, 20) | 24.20 mm × 6.92 mm | | |
| SN54HCT245 | FK (LCCC, 20) | 8.89 mm × 8.89 mm | | |
| | W (CFP, 20) | 13.09 mm × 6.92 mm | | |
| | DW (SOIC, 20) | 12.80 mm × 7.50 mm | | |
| | N (PDIP, 20) | 24.33 mm × 6.35 mm | | |
| SN74HCT245 | NS (SO, 20) | 12.60 mm × 5.30 mm | | |
| SN/4HC1245 | PW (TSSOP, 20) | 6.50 mm × 4.40 mm | | |
| | DB (SSOP, 20) | 7.80 mm × 7.20 mm | | |
| | DGS (VSSOP, 20) | 5.10 mm × 3.00 mm | | |

For all available packages, see the orderable addendum at the end of the data sheet.



To Seven Other Channels

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Logic Diagram (Positive Logic)



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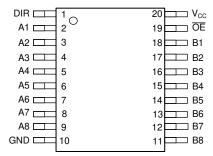
4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

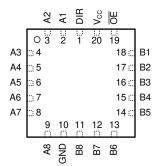
| Cł | nanges from Revision G (September 2022) to Revision H (December 2022) | Page |
|---------|---|------|
| • | Added DGS package information | 1 |
| • | Added DGS package values in the <i>Thermal Information</i> table | 5 |
| Cł | nanges from Revision F (August 2016) to Revision G (September 2022) | Page |
| | Updated the numbering format for tables, figures and cross-references throughout the document | 1 |
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| Ch | nanges from Revision E (August 2003) to Revision F (August 2016) | Page |



5 Pin Configuration and Functions



J, W, DB, DW, N, NS, PW or DGS Packages 20-Pin CDIP, CFP, SSOP, SOIC, PDIP, SO, TSSOP or VSSOP Top View



FK Package 20-Pin LCCC Top View

Pin Functions

| PIN | | TYPE ⁽¹⁾ | DESCRIPTION | | | | | |
|-----|-----------------|---------------------|--|--|--|--|--|--|
| NO. | NAME | ITPE(" | DESCRIPTION | | | | | |
| 1 | DIR | I | Direction select. High = A to B, Low = B to A | | | | | |
| 2 | A1 | I/O | Channel 1 port A | | | | | |
| 3 | A2 | I/O | Channel 2 port A | | | | | |
| 4 | A3 | I/O | Channel 3 port A | | | | | |
| 5 | A4 | I/O | Channel 4 port A | | | | | |
| 6 | A5 | I/O | Channel 5 port A | | | | | |
| 7 | A6 | I/O | Channel 6 port A | | | | | |
| 8 | A7 | I/O | Channel 7 port A | | | | | |
| 9 | A8 | I/O | Channel 8 port A | | | | | |
| 10 | GND | _ | Ground | | | | | |
| 11 | B8 | O/I | Channel 8 port B | | | | | |
| 12 | B7 | O/I | Channel 7 port B | | | | | |
| 13 | B6 | O/I | Channel 6 port B | | | | | |
| 14 | B5 | O/I | Channel 5 port B | | | | | |
| 15 | B4 | O/I | Channel 4 port B | | | | | |
| 16 | В3 | O/I | Channel 3 port B | | | | | |
| 17 | B2 | O/I | Channel 2 port B | | | | | |
| 18 | B1 | O/I | Channel 1 port B | | | | | |
| 19 | ŌĒ | I | Output enable, active low. High = all ports in high impedance mode, Low = all ports active | | | | | |
| 20 | V _{CC} | _ | Power supply | | | | | |

(1) Signal Types: I = Input, O = Output, I/O = Input or Output



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

| | | | MIN | MAX | UNIT |
|------------------|---|--|------|-----|------|
| V _{CC} | Supply voltage | | -0.5 | 7 | V |
| I _{IK} | Input clamp current ⁽²⁾ | V _I < 0 or V _I > V _{CC} | | ±20 | mA |
| I _{OK} | Output clamp current ⁽²⁾ | $V_O < 0$ or $V_O > V_{CC}$ | | ±20 | mA |
| Io | Continuous output current | $V_{\rm O}$ = 0 to $V_{\rm CC}$ | | ±35 | mA |
| | Continuous current through V _{CC} or GND | | | ±70 | mA |
| TJ | Operating virtual junction temperature | | 150 | °C | |
| T _{stg} | Storage temperature | | -65 | 150 | °C |

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability

6.2 ESD Ratings

| | | | VALUE | UNIT |
|--------------------|-------------------------|--|-------|------|
| | | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾ | ±1500 | |
| V _(ESD) | Electrostatic discharge | Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾ | ±2000 | V |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

| | - | · · · · · · · · · · · · · · · · · · · | MIN | NOM | MAX | UNIT | |
|-----------------|-------------------------------------|---------------------------------------|-----|-----|---|------|--|
| V _{CC} | Supply voltage | | 4.5 | 5 | 5.5 | V | |
| V _{IH} | High-level input voltage | V _{CC} = 4.5 V to 5.5 V | 2 | | | V | |
| V _{IL} | Low-level input voltage | V _{CC} = 4.5 V to 5.5 V | | | 0.8 | V | |
| VI | Input voltage | | 0 | | V _{CC} | V | |
| Vo | Output voltage | | 0 | | V _{CC} | V | |
| Δt/Δν | Input transition rise and fall time | | | | 500 | ns | |
| т | Operating free air temperature | SN54HCT245 | -55 | | 125 | °C | |
| T _A | Operating free-air temperature | SN74HCT245 | -40 | | V _{CC} V _{CC} 500 | C | |

(1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. See the TI application report, Implications of Slow or Floating CMOS Inputs (SCBA004).

⁽²⁾ The input and output voltage ratings may be exceeded if the input and output current ratings are observed.



6.4 Thermal Information

| | | SNx4HCT245 | | | | | | | | | |
|------------------------|--|-------------|------------|--------------|--------------|--------------|-------------|------------|-------------------|--------------------|------|
| THERMAL METRIC(1) | | J (CDIP) | W (CFP) | FK (LCCC) | DB (SSOP) | DW (SOIC) | N (PDIP) | NS (SO) | PW (TSS OP) | DGS (VSS OP) | UNIT |
| | | 20 PINS | 20 PINS | 20 PINS | 20 PINS | 20 PINS | 20 PINS | 20 PINS | 20 PINS | 20 PINS | |
| $R_{\theta JA}$ | Junction-to-ambient thermal resistance | _ | _ | _ | 84.6 | 70.4 | 43.4 | 68.9 | 94.9 | 118.4 | °C/W |
| R ₀ JC(top) | Junction-to-case (top) thermal resistance | 38.7 | 60.8 | 37.1 | 44.3 | 36.5 | 29.5 | 34.7 | 30.2 | 57.7 | °C/W |
| $R_{\theta JB}$ | Junction-to-board thermal resistance | 49.8 | 100.4 | 36.1 | 40.2 | 38.1 | 24.3 | 36.4 | 45.7 | 73.1 | °C/W |
| Ψ_{JT} | Junction-to-top characterization parameter | _ | _ | _ | 11.1 | 11.3 | 15 | 11.6 | 1.5 | 5.7 | °C/W |
| ΨЈВ | Junction-to-board characterization parameter | _ | _ | _ | 39.7 | 37.7 | 24.2 | 36 | 45.1 | 72.7 | °C/W |
| R _{θJC(bot)} | Junction-to-case (bottom) thermal resistance | 11.5 | 8.5 | 4.3 | _ | _ | _ | _ | _ | _ | °C/W |

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

| | PARAMETER | | TEST C | ONDITIO | ONS | V _{CC} | MIN | TYP | MAX | UNIT | |
|-----------------------|-----------------------------|--------------------------|-------------------------------------|-------------------------------------|-----------------------|-----------------|------|-------|-------|------|--|
| | | | | I _{OH} = | T _A = 25°C | | 4.4 | 4.499 | | | |
| | | | -20 | SN54HCT245 | | 4.4 | | | | | |
| V _{OH} | High-Level Output Voltage | ah Loval Output Voltago | | μΑ | SN74HCT245 | 4.5 V | 4.4 | | | | |
| VOH | riigii-Level Output voltage | | $V_I = V_{IH}$ or V_{IL} | | T _A = 25°C | 4.5 V | 3.98 | 4.3 | | V | |
| | | | | I _{OH} = -6 mA | SN54HCT245 | | 3.7 | | | | |
| | | | | | SN74HCT245 | | 3.84 | | | | |
| | | | | | T _A = 25°C | | | 0.001 | 0.1 | | |
| V _{OL} Low-l | | | | I _{OL} = 20 μΑ | SN54HCT245 | | | | 0.1 | | |
| | Low-Level Output Voltage | Low Lovel Output Voltage | | | SN74HCT245 | 4.5 V | | | 0.1 | | |
| | Low-Level Output Voltage | | $V_{I} = V_{IH} \text{ or } V_{IL}$ | I _{OL} = 6 mA | T _A = 25°C | 4.5 V | | 0.17 | 0.26 | | |
| | | | | | SN54HCT245 | | | | 0.4 | | |
| | | | | | SN74HCT245 | | | | 0.33 | | |
| | | DID | DIR or $V_I = V_{CC}$ or 0 | T _A = 25°C | | | | ±0.1 | ±100 | nA | |
| I _I | Input Current | OE OE | | SN54HCT245 | | 5.5 V | | | ±1000 | | |
| | | | | SN74F | HCT245 | | | | ±1000 | | |
| | | | | T _A = 25°C SN54HCT245 | | | | ±0.01 | ±0.5 | | |
| I _{OZ} | Off-State Output Current | A or B | $V_O = V_{CC}$ or 0 | | | 5.5 V | | | ±10 | μΑ | |
| | | | | SN74HCT245 | | | | | ±5 | | |
| | | | | | T _A = 25°C | | | | 8 | | |
| I _{CC} | Supply Current | | $V_I = V_{CC}$ or 0 | I _O = 0 | SN54HCT245 | 5.5 V | | | 160 | μA | |
| | | | | | SN74HCT245 | | | | 80 | 1 | |
| | | | | T _A = 25°C | | | | 1.4 | 2.4 | | |
| ΔI _{CC} (1) | Supply-Current Change | | Other inputs at 0 or | SN54HCT245 | | 5.5 V | | | 3 | mA | |
| | | | | SN74F | ICT245 | CT245 | | | 2.9 | | |



over recommended operating free-air temperature range (unless otherwise noted)

| | PARAMETER | | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|--------------------|-------------------|----|-----------------------|-----------------|-----|-----|-----|------|
| | | | T _A = 25°C | 4.5 V | | 3 | 10 | |
| C _i (2) | Input Capacitance | OE | SN54HCT245 | to | | | 10 | - i |
| | | | SN74HCT245 | 5.5 V | | | 10 | |

- (1) This is the increase in supply current for each input that is at one of the specified TTL voltage levels, rather than 0 V or V_{CC}.
- (2) Parameter C_i does not apply to transceiver I/O ports.

6.6 Switching Characteristics: C_L = 50 pF

over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 7-1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | V _{cc} | TEST CONDITIONS | MIN | TYP | MAX | UNIT | |
|------------------|-----------------|----------------|-----------------|-----------------------|-----|-----|-----|------|--|
| | | | | T _A = 25°C | | 16 | 22 | | |
| | | | 4.5 V | SN54HCT245 | | | 33 | | |
| + | A or B | B or A | | SN74HCT245 | | | 28 | ns | |
| t _{pd} | AOID | BOIA | | T _A = 25°C | | 14 | 20 | 115 | |
| | | | 5.5 V | SN54HCT245 | | | 30 | | |
| | | | | SN74HCT245 | | | 25 | | |
| | | | | T _A = 25°C | | 25 | 46 | | |
| t _{en} | | | 4.5 V | SN54HCT245 | | | 69 | | |
| | ŌĒ | A or B | | SN74HCT245 | | | 58 | ne | |
| | | | 5.5 V | T _A = 25°C | | 22 | 41 | ns | |
| | | | | SN54HCT245 | | | 62 | | |
| | | | | SN74HCT245 | | | 52 | | |
| | | | 4.5 V | T _A = 25°C | | 26 | 40 | ns | |
| | | | | SN54HCT245 | | | 60 | | |
| | ŌĒ | A or B | | SN74HCT245 | | | 50 | | |
| t _{dis} | OE | AOIB | 5.5 V | T _A = 25°C | | 23 | 36 | | |
| | | | | SN54HCT245 | | | 54 | | |
| | | | | SN74HCT245 | | | 45 | | |
| | | | | T _A = 25°C | | 9 | 12 | | |
| | | | 4.5 V | SN54HCT245 | | | 18 | | |
| | | A or D | | SN74HCT245 | | | 15 | ns | |
| t _t | | AUID | A or B 5.5 V | T _A = 25°C | | 8 | 11 | | |
| | | | | SN54HCT245 | | | 16 | | |
| | | | | SN74HCT245 | | | 14 | | |

6.7 Switching Characteristics: $C_L = 150 pF$

over recommended operating free-air temperature range, C_L = 150 pF (unless otherwise noted) (see Figure 7-1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | V _{CC} | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-----------------|-----------------|----------------|-----------------|-----------------------|-----|-----|-----|------|
| | | | | T _A = 25°C | | 20 | 30 | |
| | | D A | 4.5 V | SN54HCT245 | | | 45 | |
| | A or B | | | SN74HCT245 | | | 38 | 20 |
| t _{pd} | AOIB | B or A | 5.5 V | T _A = 25°C | | 18 | 27 | ns |
| | | | | SN54HCT245 | | | 41 | |
| | | | | SN74HCT245 | | | 34 | |
| | ŌĒ | A or B | 4.5 V 5.5 V | T _A = 25°C | | 36 | 59 | |
| | | | | SN54HCT245 | | | 89 | ns |
| | | | | SN74HCT245 | | | 74 | |
| t _{en} | | | | T _A = 25°C | | 30 | 53 | |
| | | | | SN54HCT245 | | | 80 | |
| | | | | SN74HCT245 | | | 67 | |
| | | | | T _A = 25°C | | 17 | 42 | |
| | | | 4.5 V | SN54HCT245 | | | 63 | ns |
| | | A or B | | SN74HCT245 | | | 53 | |
| t _t | | AUID | 5.5 V | T _A = 25°C | | 14 | 38 | |
| | | | | SN54HCT245 | | | 57 | |
| | | | | SN74HCT245 | | | 48 | |

6.8 Operating Characteristics

 $T_{\Lambda} = 25^{\circ}C$

| | PARAMETER | TEST CONDITIONS | TYP | UNIT |
|-----------------|---|-----------------|-----|------|
| C _{pd} | Power dissipation capacitance per transceiver | No load | 40 | pF |

6.9 Typical Characteristics

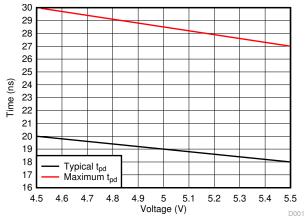
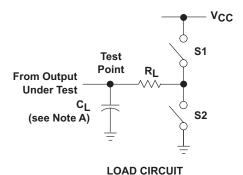


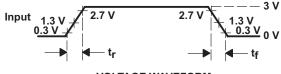
Figure 6-1. Propagation Delay Over Operating Voltage Range, T_A = 25°C



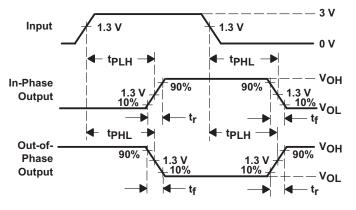
7 Parameter Measurement Information

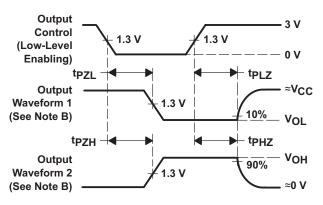


| PARAM | METER | RL | CL | S1 | S2 | |
|--------------------|----------------------------------|-------|-----------------------|--------|--------|--|
| | tPZH | 1 kΩ | 50 pF | Open | Closed | |
| 'en | t _{en} t _{PZL} | | or 150 pF | Closed | Open | |
| . | tPHZ | 1 kΩ | 50 pF | Open | Closed | |
| ^t dis | tPLZ | 1 K12 | 50 pr | Closed | Open | |
| t _{pd} or | t _t | ı | 50 pF or 150 pF | Open | Open | |



VOLTAGE WAVEFORM INPUT RISE AND FALL TIMES





VOLTAGE WAVEFORMS PROPAGATION DELAY AND OUTPUT RISE AND FALL TIMES

VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES FOR 3-STATE OUTPUTS

- A. C_L includes probe and test-fixture capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_r = 6 ns, t_f = 6 ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis}.
- F. t_{PZL} and t_{PZH} are the same as t_{en}.
- G. t_{PLH} and t_{PHL} are the same as t_{pd}.

Figure 7-1. Load Circuit and Voltage Waveforms

8 Detailed Description

8.1 Overview

The SNx4HCT245 is a bidirectional buffer with direction control and active low output enable. This device is commonly used in logic systems for isolation and increasing drive strength.

8.2 Functional Block Diagram

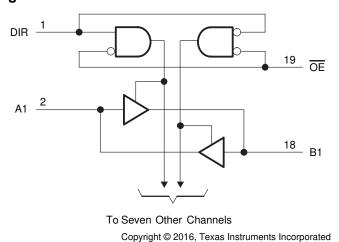


Figure 8-1. Logic Diagram (Positive Logic)

8.3 Feature Description

Voltage operating range from 4.5 V to 5.5 V is forgiving of 5-V power supply rail accuracy. Outputs can operate up to 15 LSTTL loads. This device has balanced propagation delay, typically 14 ns, and balanced output drive of ± 6 mA at 5 V. It has low power consumption of only 80- μ A maximum static supply current. The center V_{CC} and GND pin configurations minimize high-speed switching noise. Inputs are TTL-voltage compatible.

8.4 Device Functional Modes

This device is a standard '245 logic function. It has an active low output enable, a direction pin, and eight communication channels.

Table 8-1. Function Table

| INPU | ITS ⁽¹⁾ | OPERATION |
|------|--------------------|-----------------|
| ŌĒ | DIR | OFERATION |
| L | L | B data to A bus |
| L | Н | A data to B bus |
| Н | Х | Isolation |

(1) H = High Voltage Level, L = Low Voltage Level, X = Don't Care

9 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

The SNx4HCT245 is a versatile device with many available applications. The application chosen as an example here is connecting a master and slave device through a ribbon cable. This configuration is common due to losses in this type of cable.

9.2 Typical Application

Logic transceivers are commonly seen in back plane and ribbon cable applications where a signal direct from an FPGA or MCU would be too weak to reach the distant end. The transceiver acts as an amplifier to get the signal across the line, and since it is bidirectional, data can be sent from master to slave or slave to master. The additional buffer on the direction line is necessary to ensure the direction signal can always reach the distant end.

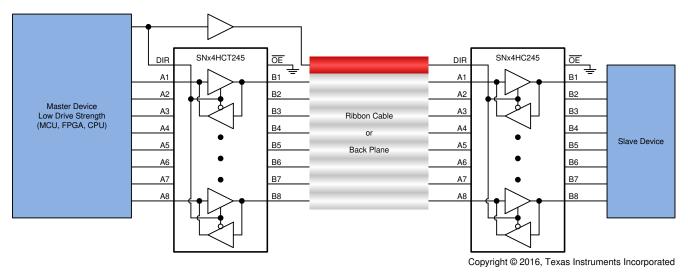


Figure 9-1. Typical application for SNx4HC245

9.2.1 Design Requirements

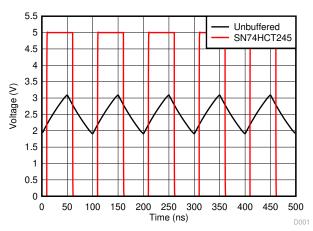
This device uses CMOS technology and has balanced output drive. Care must be taken to avoid bus contention because it can drive currents that would exceed maximum limits. Outputs can be combined to produce higher drive, but the high drive also creates faster edges into light loads, so routing and load conditions must be considered to prevent ringing.

9.2.2 Detailed Design Procedure

- 1. Recommended Input Conditions
 - Rise time and fall time specs: See (Δt/ΔV) in the Recommended Operating Conditions.
 - Specified high and low levels: See (VIH and VIL) in the Recommended Operating Conditions.
- 2. Recommended Output Conditions
 - Load currents should not exceed 35 mA per output and 70 mA total for the part.
 - Outputs should not be pulled above V_{CC}.

9.2.3 Application Curve

It is common to see significant losses in ribbon cables and back planes. The plot shown in Figure 9-2 is a simplified simulation of a ribbon cable from a 5-V, 10-MHz low drive strength source. It shows the difference between an input signal from a weak driver like an MCU or FPGA compared to a strong driver like the SN74HCT245 when measured at the distant end of the cable. By adding a high-current drive transceiver before the cable, the signal strength can be significantly improved, and subsequently the cable can be longer.



Unbuffered line is directly connected to low current source, SN74HCT245 line is buffered through the transceiver. Both signals are measured at the distant end of the ribbon cable.

Figure 9-2. Simulated Outputs From Ribbon Cable With a 5-V, 10-MHz Source

10 Power Supply Recommendations

The power supply can be any voltage between the MIN and MAX supply voltage rating located in the *Recommended Operating Conditions*. Each V_{CC} pin must have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1 μ F is recommended; if there are multiple VCC pins, then 0.01 μ F or 0.022 μ F is recommended for each power pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. A 0.1 μ F and a 1 μ F are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.

11 Layout

11.1 Layout Guidelines

When using multiple-bit logic devices, inputs should never float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only six channels of an eight channel transceiver are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they are tied to GND or V_{CC} , whichever makes more sense or is more convenient.

The output enable pin disables the output section of the part when asserted. This does not disable the input section of the IOs, so they cannot float when disabled.

Figure 11-1 shows the proper method to terminate unused channels using a large resistance (in this example, $10\text{-k}\Omega$ resistors). This avoids overloading the outputs , and maintains a valid voltage on the inputs. Note that it is also valid to tie both sides of an unused transceiver directly to ground or V_{CC} ; however, the two sides must never be tied to different states directly.

11.2 Layout Example

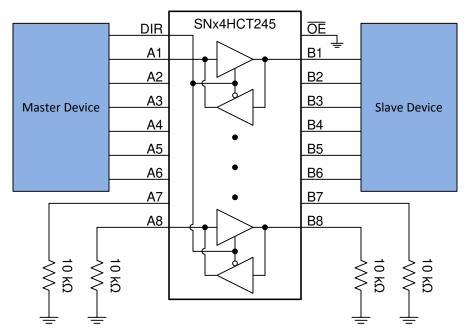


Figure 11-1. Proper Termination of OE Pin And Unused Channels 7 and 8

12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation see the following:

Implications of Slow or Floating CMOS Inputs (SCBA004)

12.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 12-1. Related Links

| PARTS | PRODUCT FOLDER | SAMPLE & BUY | TECHNICAL DOCUMENTS | TOOLS & SOFTWARE | SUPPORT & COMMUNITY |
|------------|----------------|--------------|---------------------|---------------------|---------------------|
| SN54HCT245 | Click here | Click here | Click here | Click here | Click here |
| SN74HCT245 | Click here | Click here | Click here | Click here | Click here |

12.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.4 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

12.5 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

12.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.7 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





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PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan | Lead finish/ Ball material | MSL Peak Temp | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|------------|--------------|--------------------|------|----------------|---------------------|-------------------------------|--------------------|--------------|-------------------------------------|---------|
| 5962-8550601VRA | ACTIVE | CDIP | J | 20 | 20 | Non-RoHS & Green | SNPB | N / A for Pkg Type | -55 to 125 | 5962-8550601VR A SNV54HCT245J | Samples |
| 5962-8550601VSA | ACTIVE | CFP | W | 20 | 25 | Non-RoHS & Green | SNPB | N / A for Pkg Type | -55 to 125 | 5962-8550601VS A SNV54HCT245W | Samples |
| 85506012A | ACTIVE | LCCC | FK | 20 | 55 | Non-RoHS & Green | SNPB | N / A for Pkg Type | -55 to 125 | 85506012A SNJ54HCT 245FK | Samples |
| 8550601RA | ACTIVE | CDIP | J | 20 | 20 | Non-RoHS & Green | SNPB | N / A for Pkg Type | -55 to 125 | 8550601RA SNJ54HCT245J | Samples |
| JM38510/65553BRA | ACTIVE | CDIP | J | 20 | 20 | Non-RoHS & Green | SNPB | N / A for Pkg Type | -55 to 125 | JM38510/ 65553BRA | Samples |
| JM38510/65553BSA | ACTIVE | CFP | W | 20 | 25 | Non-RoHS & Green | SNPB | N / A for Pkg Type | -55 to 125 | JM38510/ 65553BSA | Samples |
| M38510/65553BRA | ACTIVE | CDIP | J | 20 | 20 | Non-RoHS & Green | SNPB | N / A for Pkg Type | -55 to 125 | JM38510/ 65553BRA | Samples |
| M38510/65553BSA | ACTIVE | CFP | W | 20 | 25 | Non-RoHS & Green | SNPB | N / A for Pkg Type | -55 to 125 | JM38510/ 65553BSA | Samples |
| SN54HCT245J | ACTIVE | CDIP | J | 20 | 20 | Non-RoHS & Green | SNPB | N / A for Pkg Type | -55 to 125 | SN54HCT245J | Samples |
| SN74HCT245DBR | ACTIVE | SSOP | DB | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | HT245 | Samples |
| SN74HCT245DBRG4 | ACTIVE | SSOP | DB | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | HT245 | Samples |
| SN74HCT245DGSR | ACTIVE | VSSOP | DGS | 20 | 5000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | HT245 | Samples |
| SN74HCT245DWR | ACTIVE | SOIC | DW | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | HCT245 | Samples |
| SN74HCT245DWRE4 | ACTIVE | SOIC | DW | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | HCT245 | Samples |
| SN74HCT245DWRG4 | ACTIVE | SOIC | DW | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | HCT245 | Samples |
| SN74HCT245N | ACTIVE | PDIP | N | 20 | 20 | RoHS & Green | NIPDAU | N / A for Pkg Type | -40 to 85 | SN74HCT245N | Samples |
| SN74HCT245NE4 | ACTIVE | PDIP | N | 20 | 20 | RoHS & Green | NIPDAU | N / A for Pkg Type | -40 to 85 | SN74HCT245N | Samples |





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| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan | Lead finish/ Ball material | MSL Peak Temp | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|------------|--------------|--------------------|------|----------------|---------------------|-------------------------------|--------------------|--------------|--------------------------------|---------|
| SN74HCT245NSR | ACTIVE | SO | NS | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | HCT245 | Samples |
| SN74HCT245PWR | ACTIVE | TSSOP | PW | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | HT245 | Samples |
| SN74HCT245PWRE4 | ACTIVE | TSSOP | PW | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | HT245 | Samples |
| SN74HCT245PWRG4 | ACTIVE | TSSOP | PW | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | HT245 | Samples |
| SNJ54HCT245FK | ACTIVE | LCCC | FK | 20 | 55 | Non-RoHS & Green | SNPB | N / A for Pkg Type | -55 to 125 | 85506012A SNJ54HCT 245FK | Samples |
| SNJ54HCT245J | ACTIVE | CDIP | J | 20 | 20 | Non-RoHS & Green | SNPB | N / A for Pkg Type | -55 to 125 | 8550601RA SNJ54HCT245J | Samples |
| SNJ54HCT245W | ACTIVE | CFP | W | 20 | 25 | Non-RoHS & Green | SNPB | N / A for Pkg Type | -55 to 125 | SNJ54HCT245W | Samples |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.





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(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN54HCT245, SN54HCT245-SP, SN74HCT245:

Catalog: SN74HCT245, SN54HCT245

Military: SN54HCT245

Space: SN54HCT245-SP

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications
- Space Radiation tolerant, ceramic packaging and qualified for use in Space-based application



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TAPE AND REEL INFORMATION



TAPE DIMENSIONS + K0 - P1 - B0 W Cavity - A0 -

| A0 | Dimension designed to accommodate the component width |
|----|---|
| В0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-----------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| SN74HCT245DBR | SSOP | DB | 20 | 2000 | 330.0 | 16.4 | 8.2 | 7.5 | 2.5 | 12.0 | 16.0 | Q1 |
| SN74HCT245DBR | SSOP | DB | 20 | 2000 | 330.0 | 16.4 | 8.2 | 7.5 | 2.5 | 12.0 | 16.0 | Q1 |
| SN74HCT245DGSR | VSSOP | DGS | 20 | 5000 | 330.0 | 16.4 | 5.4 | 5.4 | 1.45 | 8.0 | 16.0 | Q1 |
| SN74HCT245DWR | SOIC | DW | 20 | 2000 | 330.0 | 24.4 | 10.9 | 13.3 | 2.7 | 12.0 | 24.0 | Q1 |
| SN74HCT245DWR | SOIC | DW | 20 | 2000 | 330.0 | 24.4 | 10.9 | 13.3 | 2.7 | 12.0 | 24.0 | Q1 |
| SN74HCT245NSR | so | NS | 20 | 2000 | 330.0 | 24.4 | 8.4 | 13.0 | 2.5 | 12.0 | 24.0 | Q1 |
| SN74HCT245NSR | so | NS | 20 | 2000 | 330.0 | 24.4 | 8.4 | 13.0 | 2.5 | 12.0 | 24.0 | Q1 |
| SN74HCT245PWR | TSSOP | PW | 20 | 2000 | 330.0 | 16.4 | 6.95 | 7.0 | 1.4 | 8.0 | 16.0 | Q1 |
| SN74HCT245PWR | TSSOP | PW | 20 | 2000 | 330.0 | 16.4 | 6.95 | 7.0 | 1.4 | 8.0 | 16.0 | Q1 |
| SN74HCT245PWRG4 | TSSOP | PW | 20 | 2000 | 330.0 | 16.4 | 6.95 | 7.0 | 1.4 | 8.0 | 16.0 | Q1 |
| SN74HCT245PWRG4 | TSSOP | PW | 20 | 2000 | 330.0 | 16.4 | 6.95 | 7.0 | 1.4 | 8.0 | 16.0 | Q1 |



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*All dimensions are nominal

| All difficultions are norminal | | | | | | | |
|--------------------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| SN74HCT245DBR | SSOP | DB | 20 | 2000 | 356.0 | 356.0 | 35.0 |
| SN74HCT245DBR | SSOP | DB | 20 | 2000 | 356.0 | 356.0 | 35.0 |
| SN74HCT245DGSR | VSSOP | DGS | 20 | 5000 | 356.0 | 356.0 | 35.0 |
| SN74HCT245DWR | SOIC | DW | 20 | 2000 | 367.0 | 367.0 | 45.0 |
| SN74HCT245DWR | SOIC | DW | 20 | 2000 | 356.0 | 356.0 | 41.0 |
| SN74HCT245NSR | SO | NS | 20 | 2000 | 367.0 | 367.0 | 45.0 |
| SN74HCT245NSR | so | NS | 20 | 2000 | 356.0 | 356.0 | 41.0 |
| SN74HCT245PWR | TSSOP | PW | 20 | 2000 | 356.0 | 356.0 | 35.0 |
| SN74HCT245PWR | TSSOP | PW | 20 | 2000 | 356.0 | 356.0 | 35.0 |
| SN74HCT245PWRG4 | TSSOP | PW | 20 | 2000 | 356.0 | 356.0 | 35.0 |
| SN74HCT245PWRG4 | TSSOP | PW | 20 | 2000 | 356.0 | 356.0 | 35.0 |



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TUBE

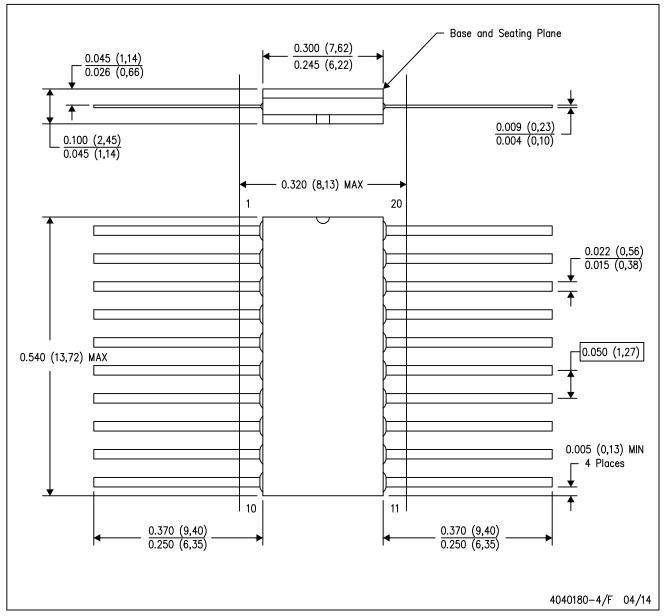


*All dimensions are nominal

| Device | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (µm) | B (mm) |
|------------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| 5962-8550601VSA | W | CFP | 20 | 25 | 506.98 | 26.16 | 6220 | NA |
| 85506012A | FK | LCCC | 20 | 55 | 506.98 | 12.06 | 2030 | NA |
| JM38510/65553BSA | W | CFP | 20 | 25 | 506.98 | 26.16 | 6220 | NA |
| M38510/65553BSA | W | CFP | 20 | 25 | 506.98 | 26.16 | 6220 | NA |
| SN74HCT245N | N | PDIP | 20 | 20 | 506 | 13.97 | 11230 | 4.32 |
| SN74HCT245NE4 | N | PDIP | 20 | 20 | 506 | 13.97 | 11230 | 4.32 |
| SNJ54HCT245FK | FK | LCCC | 20 | 55 | 506.98 | 12.06 | 2030 | NA |
| SNJ54HCT245W | W | CFP | 20 | 25 | 506.98 | 26.16 | 6220 | NA |

W (R-GDFP-F20)

CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
- E. Falls within Mil-Std 1835 GDFP2-F20







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



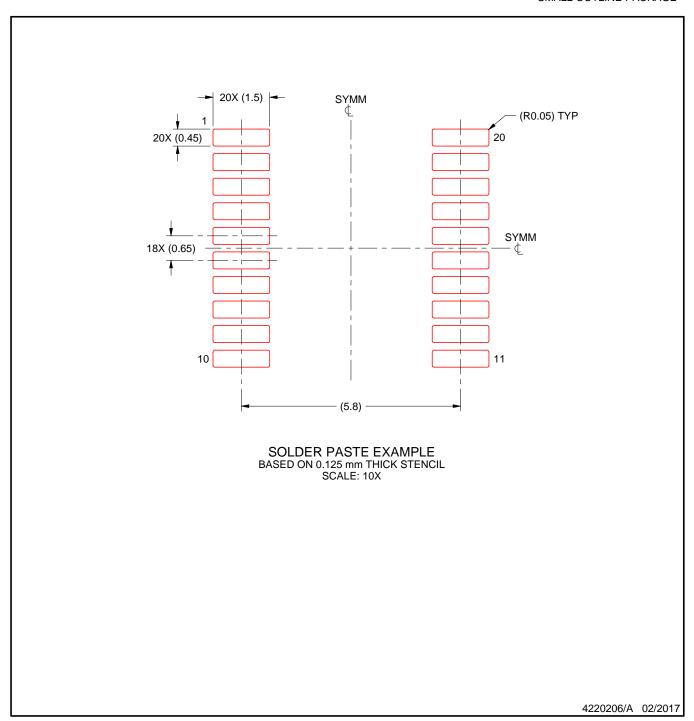


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



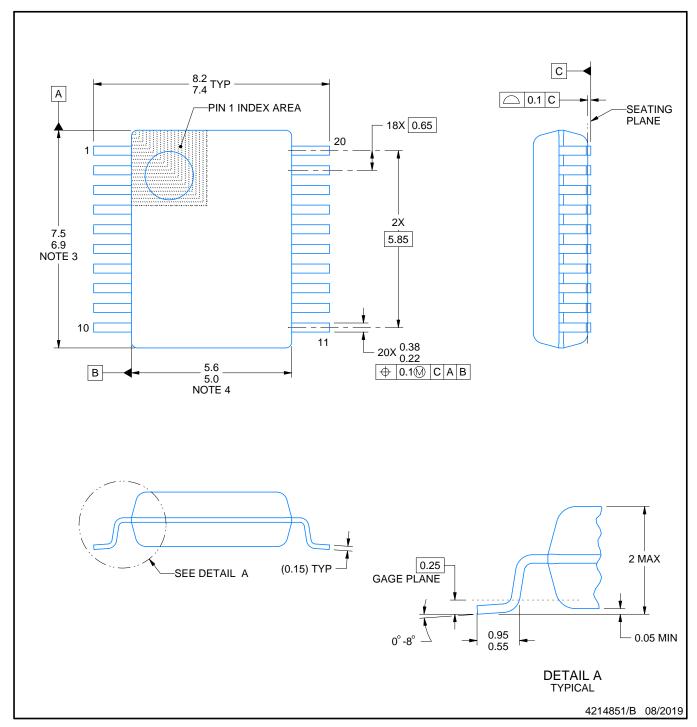


NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-150.



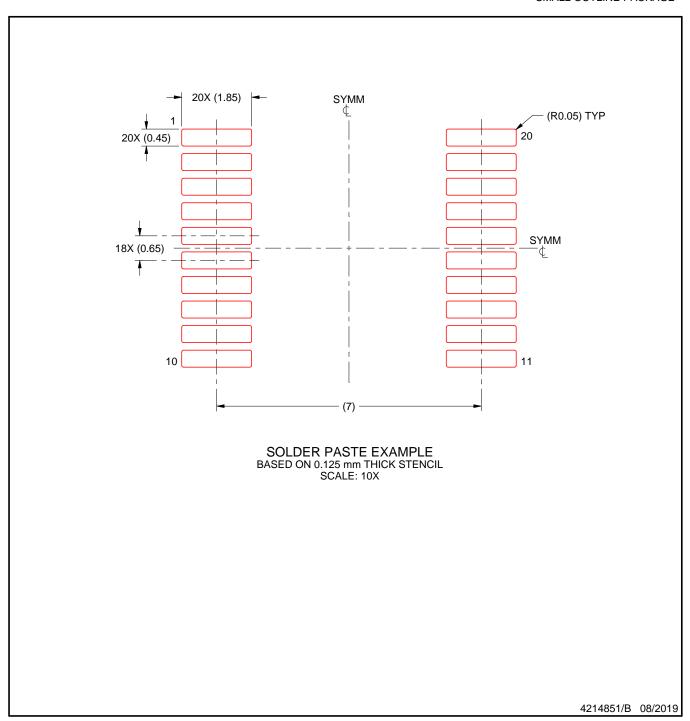


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.

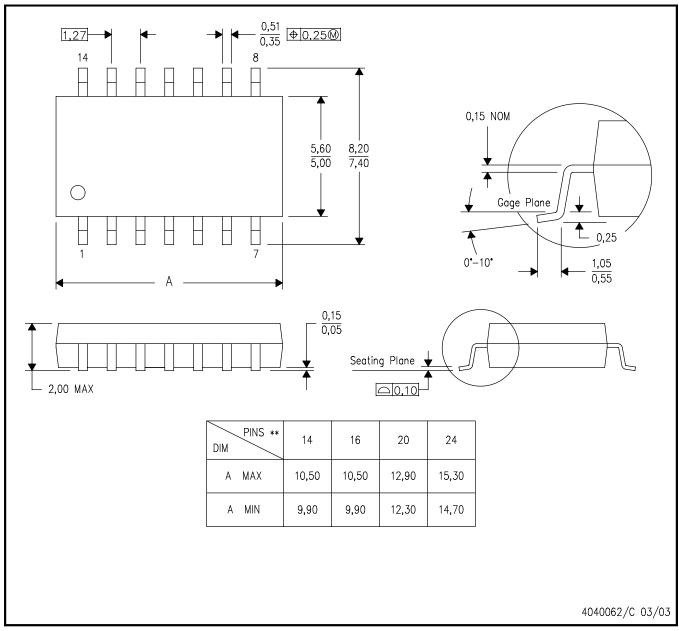


MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

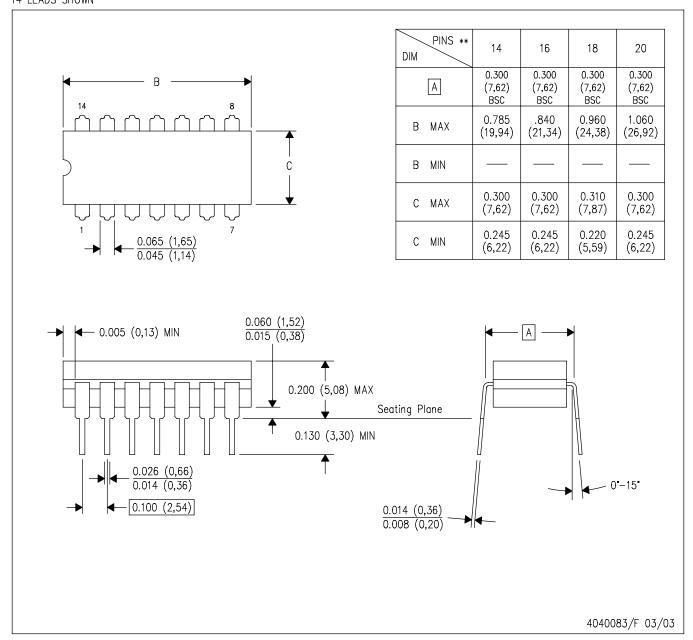
PLASTIC SMALL-OUTLINE PACKAGE



- All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



14 LEADS SHOWN

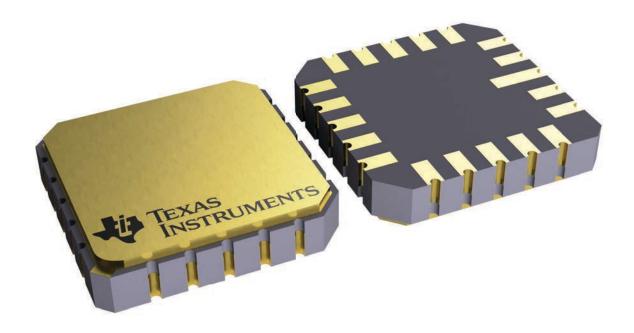


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN

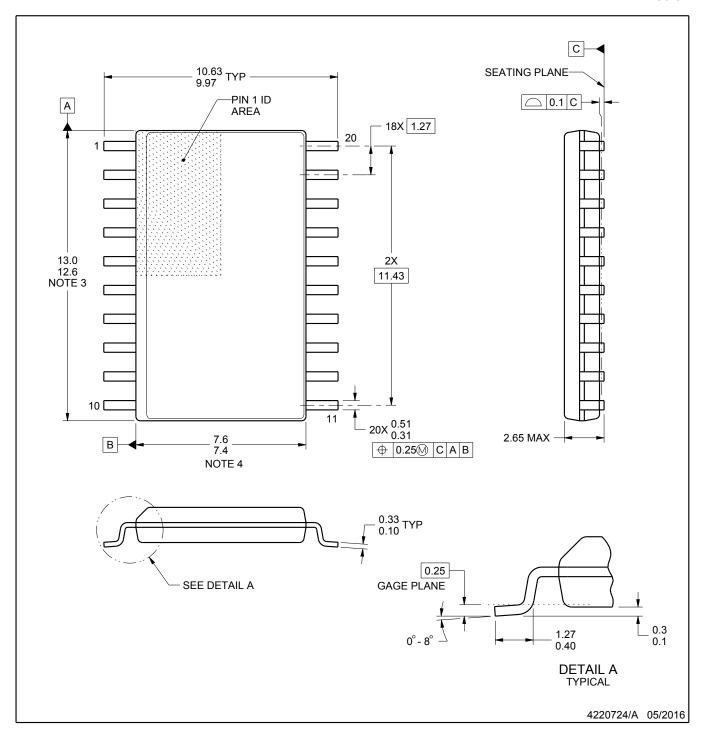


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SOIC



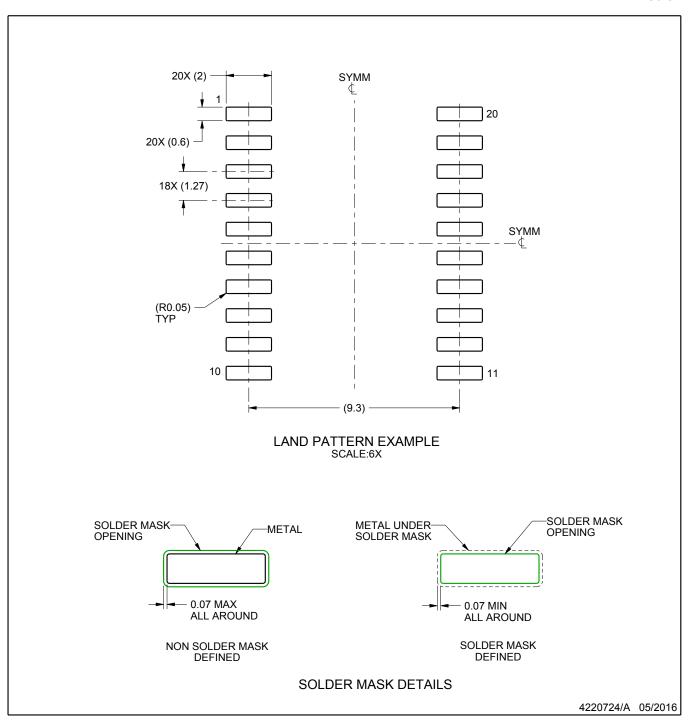
- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC

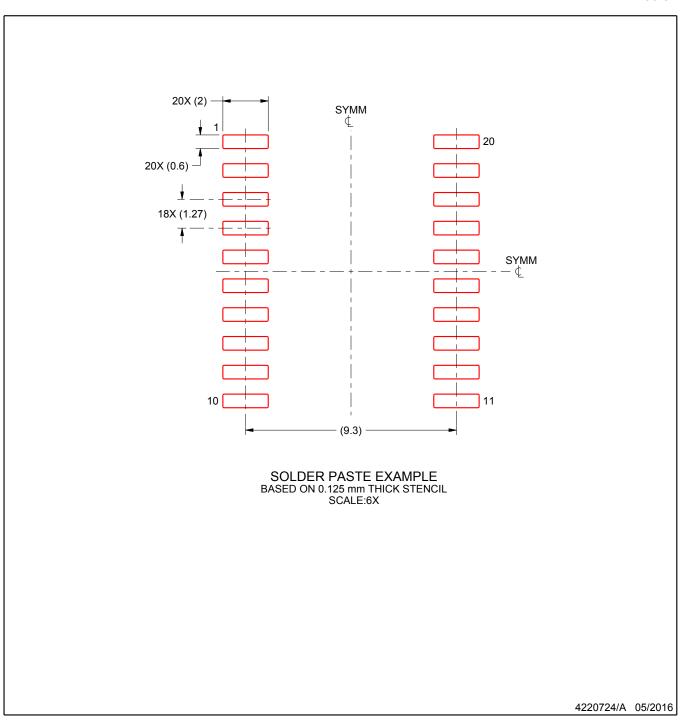


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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